

## Notice of References Cited

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Application/Control No.	Applicant(s)/Pate	nt Under
10/025,477	Reexamination KIM, CHANG GC	DNE
Examiner	 Art Unit	
Amr Awad	2675	Page 1 of 1

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	Α	US-6,509,894 B1	01-2003	Maekawa et al.	345/211
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